

Notice of References CitedApplication/Control No.
09/961,134Applicant(s)/Patent Under
Reexamination
TSAI ET AL.Examiner
Edna Wong

2045104

Art Unit
1753

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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Application/Control No.

09/961,134

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Edna Wong

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Art Unit

1753

Page 1 of 1

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	Examiner Edna Wong	Art Unit 1753	Page 1 of 1

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